

The RF Sub-Micron MOSFET Line
RF Power Field Effect Transistors
N-Channel Enhancement-Mode Lateral MOSFETs

Designed for class A and class AB PCN and PCS base station applications at frequencies up to 2600 MHz. Suitable for FM, TDMA, CDMA, and multicarrier amplifier applications.

- Specified Two-Tone Performance @ 2000 MHz, 26 Volts
Output Power = 10 Watts (PEP)
Power Gain = 11 dB
Efficiency = 30%
Intermodulation Distortion = -30 dBc
- Specified Single-Tone Performance @ 2000 MHz, 26 Volts
Output Power = 10 Watts (CW)
Power Gain = 11 dB
Efficiency = 40%
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- S-Parameter Characterization at High Bias Levels
- Excellent Thermal Stability
- Capable of Handling 10:1 VSWR, @ 26 Vdc, 2000 MHz, 10 Watts (CW) Output Power
- Gold Metallization for Improved Reliability

MRF282S
MRF282Z

**10 W, 2000 MHz, 26 V
LATERAL N-CHANNEL
BROADBAND
RF POWER MOSFETs**



CASE 458-03, STYLE 1
(MRF282S)



CASE 458A-01, STYLE 1
(MRF282Z)

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	65	Vdc
Gate-Source Voltage	V _{GS}	±20	Vdc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	60 0.34	Watts W/°C
Storage Temperature Range	T _{stg}	-65 to +150	°C
Operating Junction Temperature	T _J	200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R _{θJC}	2.9	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit

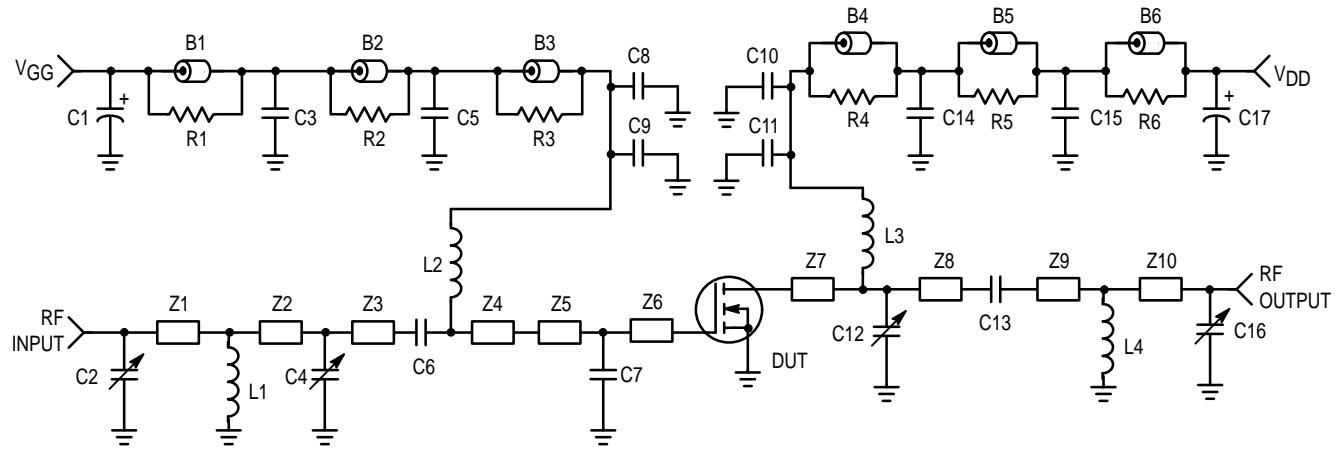
OFF CHARACTERISTICS

Drain-Source Breakdown Voltage (V _{GS} = 0, I _D = 10 μAdc)	V _{(BR)DSS}	65	—	—	Vdc
Zero Gate Voltage Drain Current (V _{DS} = 28 Vdc, V _{GS} = 0)	I _{DSS}	—	—	1.0	μAdc
Gate-Source Leakage Current (V _{GS} = 20 Vdc, V _{DS} = 0)	I _{GSS}	—	—	1.0	μAdc

NOTE – **CAUTION** – MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

ELECTRICAL CHARACTERISTICS continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

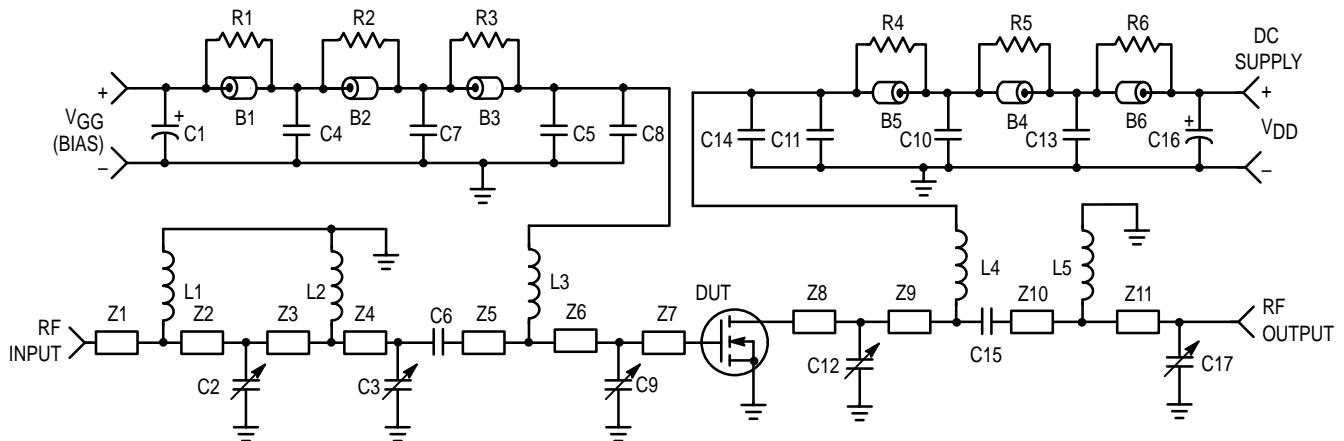
Characteristic	Symbol	Min	Typ	Max	Unit
ON CHARACTERISTICS					
Gate Threshold Voltage ($V_{DS} = 10 \text{ Vdc}$, $I_D = 50 \mu\text{A}_{\text{dc}}$)	$V_{GS(\text{th})}$	2.0	3.0	4.0	Vdc
Drain–Source On–Voltage ($V_{GS} = 10 \text{ Vdc}$, $I_D = 0.5 \text{ A}_{\text{dc}}$)	$V_{DS(\text{on})}$	—	0.4	0.6	Vdc
Forward Transconductance ($V_{DS} = 10 \text{ Vdc}$, $I_D = 0.5 \text{ A}_{\text{dc}}$)	g_{fs}	0.5	0.7	—	S
Gate Quiescent Voltage ($V_{DS} = 26 \text{ Vdc}$, $I_D = 75 \text{ mA}_{\text{dc}}$)	$V_{GS(q)}$	3.0	4.0	5.0	Vdc
DYNAMIC CHARACTERISTICS					
Input Capacitance ($V_{DS} = 26 \text{ Vdc}$, $V_{GS} = 0$, $f = 1.0 \text{ MHz}$)	C_{iss}	—	15	—	pF
Output Capacitance ($V_{DS} = 26 \text{ Vdc}$, $V_{GS} = 0$, $f = 1.0 \text{ MHz}$)	C_{oss}	—	8.0	—	pF
Reverse Transfer Capacitance ($V_{DS} = 26 \text{ Vdc}$, $V_{GS} = 0$, $f = 1.0 \text{ MHz}$)	C_{rss}	—	0.45	—	pF
FUNCTIONAL TESTS (In Motorola Test Fixture)					
Common–Source Power Gain ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 2000.0 \text{ MHz}$, $f_2 = 2000.1 \text{ MHz}$)	G_{ps}	11	12.6	—	dB
Drain Efficiency ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 2000.0 \text{ MHz}$, $f_2 = 2000.1 \text{ MHz}$)	η	30	34	—	%
Intermodulation Distortion ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 2000.0 \text{ MHz}$, $f_2 = 2000.1 \text{ MHz}$)	I_{MD}	—	-32.5	-30	dBc
Input Return Loss ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 2000.0 \text{ MHz}$, $f_2 = 2000.1 \text{ MHz}$)	I_{RL}	10	14	—	dB
Common–Source Power Gain ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 1930.0 \text{ MHz}$, $f_2 = 1930.1 \text{ MHz}$)	G_{ps}	11	12.6	—	dB
Drain Efficiency ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 1930.0 \text{ MHz}$, $f_2 = 1930.1 \text{ MHz}$)	η	—	30	—	%
Intermodulation Distortion ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 1930.0 \text{ MHz}$, $f_2 = 1930.1 \text{ MHz}$)	I_{MD}	—	-32.5	—	dBc
Input Return Loss ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ (PEP), $I_{DQ} = 75 \text{ mA}$, $f_1 = 1930.0 \text{ MHz}$, $f_2 = 1930.1 \text{ MHz}$)	I_{RL}	10	14	—	dB
Common–Source Power Gain ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ CW, $I_{DQ} = 75 \text{ mA}$, $f = 2000.0 \text{ MHz}$)	G_{ps}	11	12.3	—	dB
Drain Efficiency ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ CW, $I_{DQ} = 75 \text{ mA}$, $f = 2000.0 \text{ MHz}$)	η	40	45	—	%
Output Mismatch Stress ($V_{DD} = 26 \text{ Vdc}$, $P_{out} = 10 \text{ W}$ CW, $I_{DQ} = 75 \text{ mA}$, $f_1 = 2000.0 \text{ MHz}$, $f_2 = 2000.1 \text{ MHz}$, Load VSWR = 10:1, All Phase Angles at Frequency of Test)	Ψ	No Degradation In Output Power			



B1, B2, B3, Ferrite Bead, Ferroxcube, 56–590–65–3B
 B4, B5, B6
 C1, C17 470 μ F, Electrolytic Capacitor, Mallory
 C2, C4, C12 0.6–4.5 pF, Variable Capacitor, Johanson
 C3, C15 0.1 μ F, Chip Capacitor, Kemet
 C5, C14 1000 pF, B Case Chip Capacitor, ATC
 C6, C8, C10, C13 12 pF, B Case Chip Capacitor, ATC
 C7 1.8 pF, B Case Chip Capacitor, ATC
 C9, C11 100 pF, B Case Chip Capacitor, ATC
 C16 0.4–2.5 pF, Variable Capacitor, Johanson
 L1 Straight Wire, 21 AWG, 0.3"
 L2 8 Turns, 0.042" ID, 24 AWG, Enamel
 L3 9 Turns, 0.046" ID, 26 AWG, Enamel
 L4 3 Turns, 0.048" ID, 25 AWG, Enamel

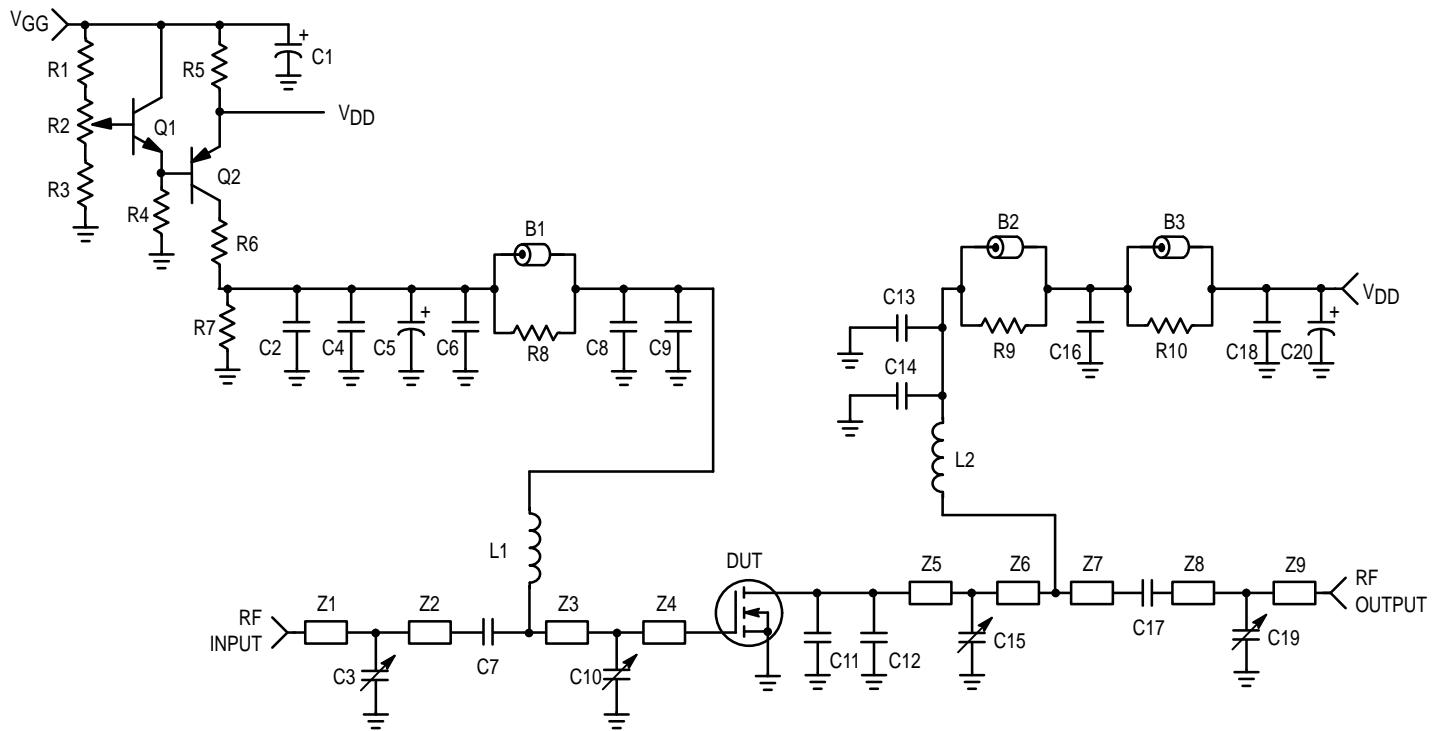
R1, R2, R3, 12 Ω , 0.2 W Chip Resistor, Rohm
 R4, R5, R6
 Z1 0.155" x 0.08" Microstrip
 Z2 0.280" x 0.08" Microstrip
 Z3 0.855" x 0.08" Microstrip
 Z4 0.483" x 0.08" Microstrip
 Z5 0.200" x 0.330" Microstrip
 Z6 0.220" x 0.330" Microstrip
 Z7 0.490" x 0.330" Microstrip
 Z8 0.510" x 0.08" Microstrip
 Z9 0.990" x 0.08" Microstrip
 Z10 0.295" x 0.08" Microstrip
 Board 35 Mils Glass Teflon®, Arlon GX-300,
 $\epsilon_r = 2.55$
 Input/Output Connectors Type N Flange Mount

Figure 1. Schematic of 1.93 – 2.0 GHz Broadband Test Circuit



B1, B2, B3,	Ferrite Bead, Fair Rite, (2743021446)	R1, R2, R3,	12 Ω, 1/8 W Fixed Film Chip Resistor,
B4, B5, B6		R4, R5, R6	0.08" x 0.13"
C1, C16	470 μF, 63 V, Electrolytic Capacitor, Mallory	W1, W2	Beryllium Copper, 0.010" x 0.110" x 0.210"
C2, C9, C12	0.6–4.5 pF, Variable Capacitor, Johanson Gigatrim	Z1	0.122" x 0.08" Microstrip
C3	0.8–4.5 pF, Variable Capacitor, Johanson Gigatrim	Z2	0.650" x 0.08" Microstrip
C4, C13	0.1 μF, Chip Capacitor	Z3	0.160" x 0.08" Microstrip
C5, C14	100 pF, B Case Chip Capacitor, ATC	Z4	0.030" x 0.08" Microstrip
C6, C8, C11, C15	12 pF, B Case Chip Capacitor, ATC	Z5	0.045" x 0.08" Microstrip
C7, C10	1000 pF, B Case Chip Capacitor, ATC	Z6	0.291" x 0.08" Microstrip
C17	0.1 pF, B Case Chip Capacitor, ATC	Z7	0.483" x 0.330" Microstrip
L1	3 Turns, 27 AWG, 0.087" OD, 0.050" ID, 0.053" Long, 6.0 nH	Z8	0.414" x 0.330" Microstrip
L2	5 Turns, 27 AWG, 0.087" OD, 0.050" ID, 0.091" Long, 15 nH	Z9	0.392" x 0.08" Microstrip
L3, L4	9 Turns, 26 AWG, 0.080" OD, 0.046" ID, 0.170" Long, 30.8 nH	Z10	0.070" x 0.08" Microstrip
L5	4 Turns, 27 AWG, 0.087" OD, 0.050" ID, 0.078" Long, 10 nH	Z11	1.110" x 0.08" Microstrip
		Board	1 = 0.03 Glass Teflon®, Arlon GX-0300-55-22, 2 oz Copper, 3 x 5" Dimension, 0.030", $\epsilon_r = 2.55$

Figure 2. Schematic of 1.81 – 1.88 GHz Broadband Test Circuit

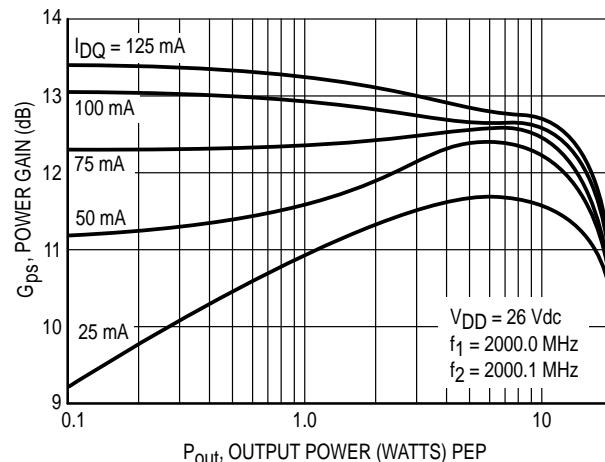
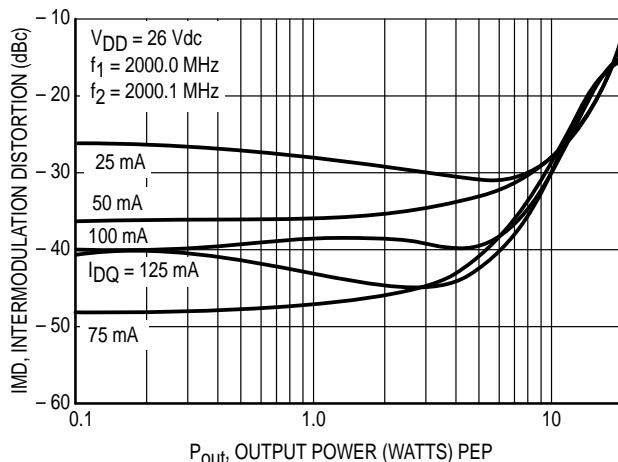
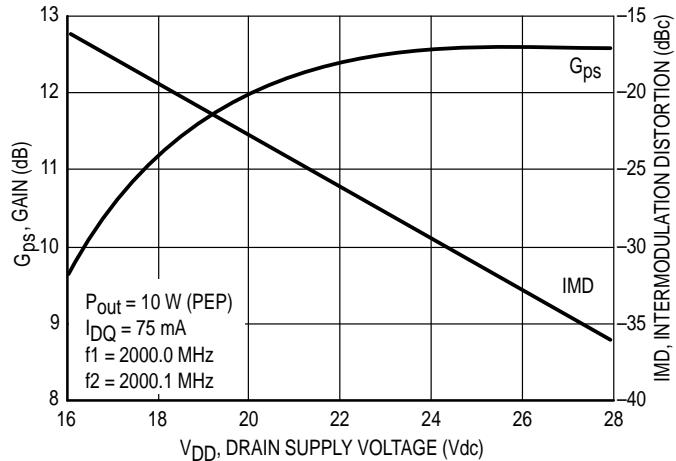
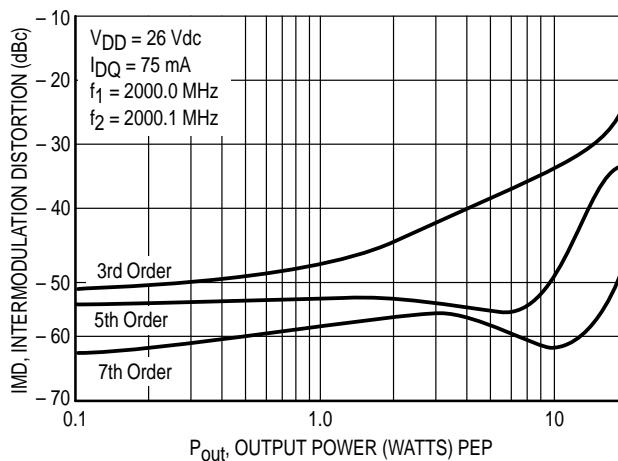
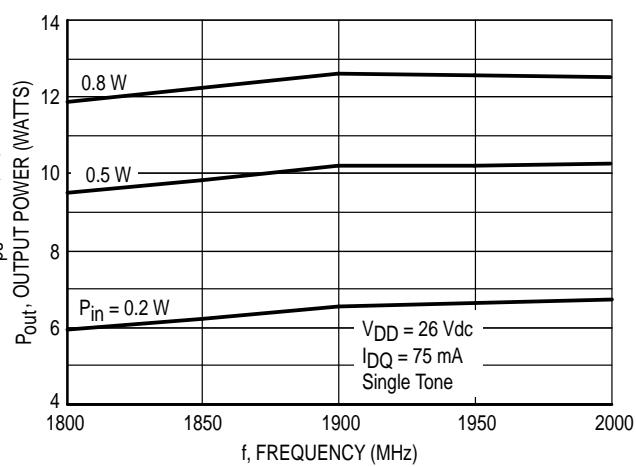
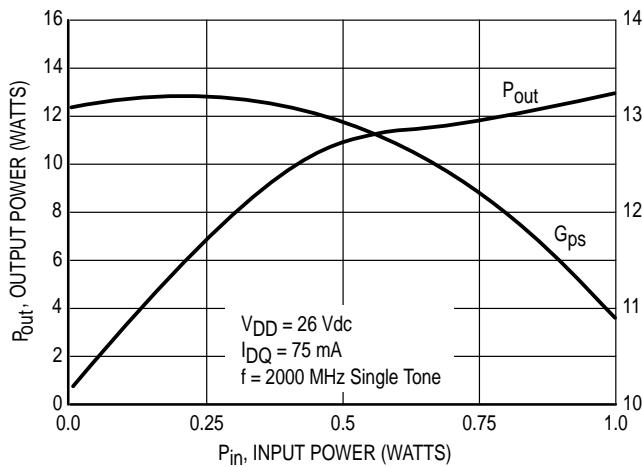


B1, B2, B3, Ferrite Bead, Ferroxcube, 56-590-65-3B
 C1, C20 470 μ F, 63 V, Electrolytic Capacitor, Mallory
 C2 0.01 μ F, B Case Chip Capacitor, ATC
 C3, C10, C15 0.6–4.5 pF, Variable Capacitor, Johanson
 C4, C16 0.02 μ F, B Case Chip Capacitor, ATC
 C5 100 μ F, 50 V, Electrolytic Capacitor, Sprague
 C6, C7, C9, 12 pF, B Case Chip Capacitor, ATC
 C14, C17
 C8, C13 51 pF, B Case Chip Capacitor, ATC
 C11, C12 0.3 pF, B Case Chip Capacitor, ATC
 C18 0.1 μ F, Chip Capacitor, Kemet
 C19 0.4–2.5 pF, Variable Capacitor, Johanson
 L1 8 Turns, 0.042" ID, 24 AWG, Enamel
 L2 9 Turns, 0.046" ID, 26 AWG, Enamel
 Q1 NPN, 15 W, Bipolar Transistor, MJD310
 Q2 PNP, 15 W, Bipolar Transistor, MJD320
 R1 200 Ω , Axial, 1/4 W Resistor

R2	1.0 k Ω , 1/2 W Potentiometer
R3	13 k Ω , Axial, 1/4 W Resistor
R4, R6, R7	390 Ω , 1/8 W Chip Resistor, Rohm
R5	1.0 Ω , 10 W 1% Resistor, DALE
R8, R9, R10	12 Ω , 1/8 W Chip Resistor, Rohm
Z1	0.624" x 0.08" Microstrip
Z2	0.725" x 0.08" Microstrip
Z3	0.455" x 0.08" Microstrip
Z4	0.530" x 0.330" Microstrip
Z5	0.280" x 0.330" Microstrip
Z6	0.212" x 0.330" Microstrip
Z7	0.408" x 0.08" Microstrip
Z8	0.990" x 0.08" Microstrip
Z9	0.295" x 0.08" Microstrip
Board	35 Mils Glass Teflon®, Arlon GX-0300, $\epsilon_r = 2.55$
Input/Output	Type N Flange Mount RF55-22, Connectors, Omni Spectra

Figure 3. Schematic of Class A Test Circuit

TYPICAL CHARACTERISTICS



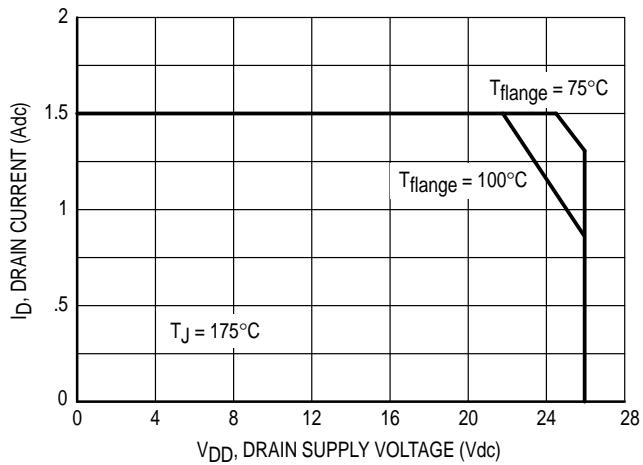


Figure 10. Class A DC Safe Operating Area

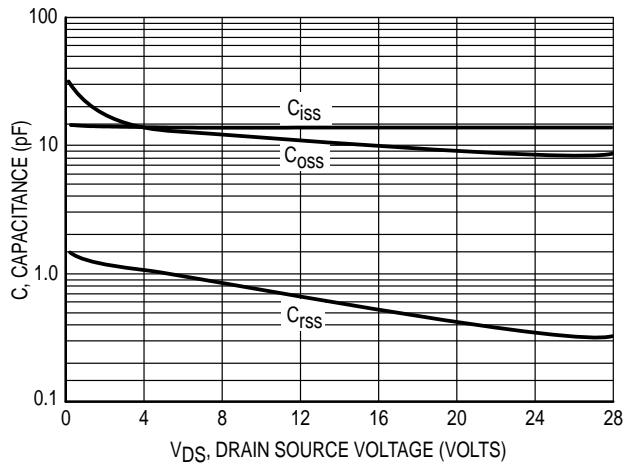


Figure 11. Capacitance versus Drain Source Voltage

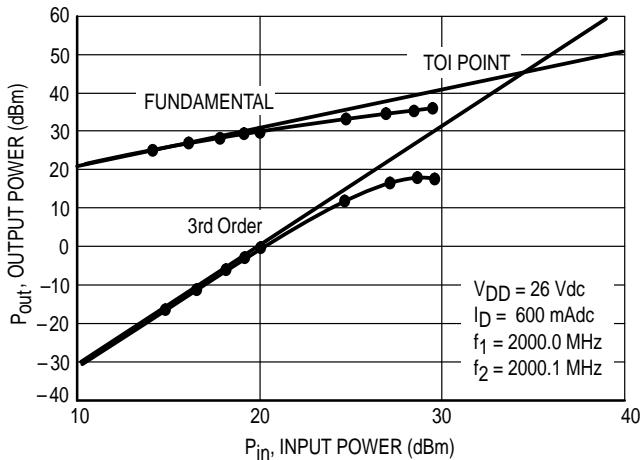


Figure 12. Class A Third Order Intercept Point

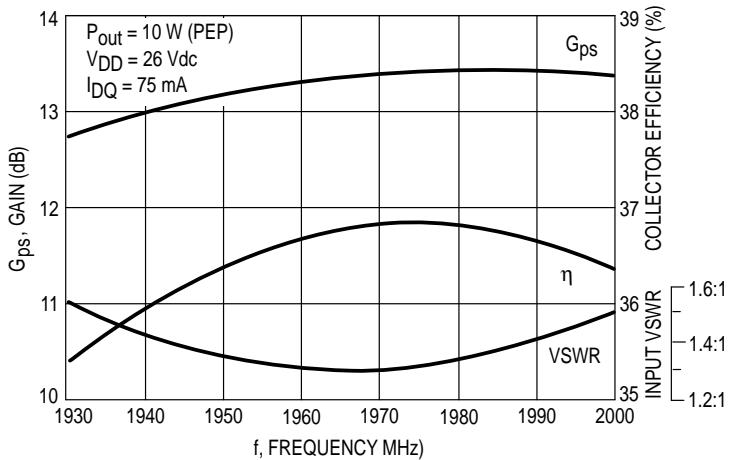
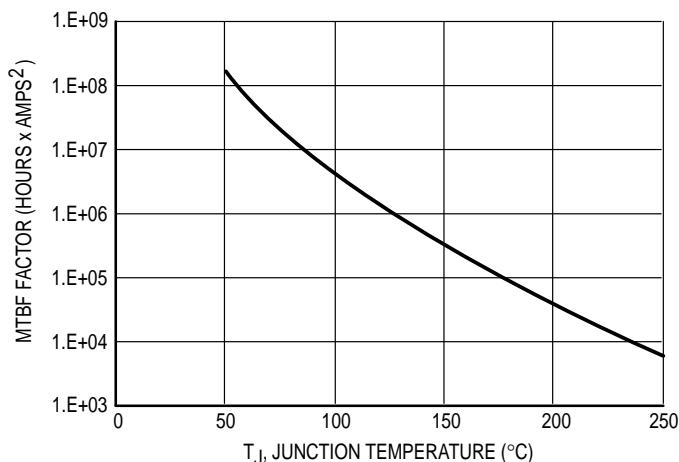
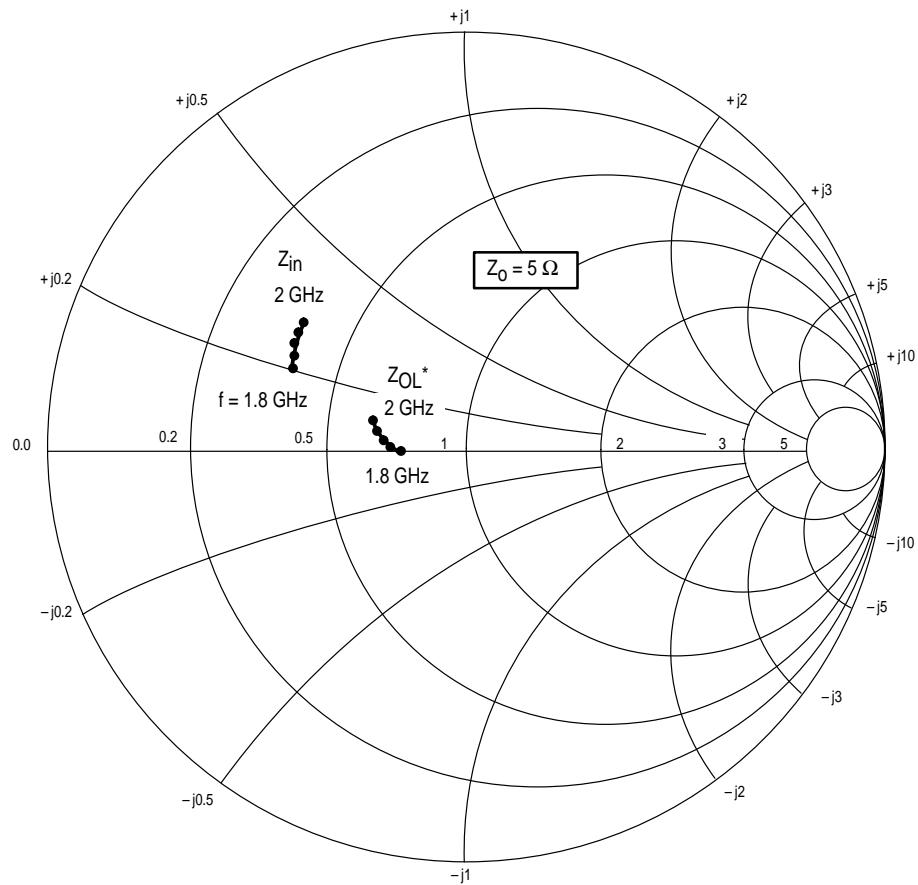


Figure 13. Performance in Broadband Circuit



This graph displays calculated MTBF in hours \times ampere 2 drain current. Life tests at elevated temperature have correlated to better than $\pm 10\%$ of the theoretical prediction for metal failure. Divide MTBF factor by I_D^2 for MTBF in a particular application.

Figure 14. MTBF Factor versus Junction Temperature



$V_{CC} = 26 \text{ V}$, $I_{CQ} = 75 \text{ mA}$, $P_{out} = 10 \text{ W}$ (PEP)

f MHz	$Z_{in}(1)$ Ω	Z_{OL}^* Ω
1800	$2.1 + j1.0$	$3.8 - j0.15$
1860	$2.05 + j1.15$	$3.77 - j0.13$
1900	$2.0 + j1.2$	$3.75 - j0.1$
1960	$1.9 + j1.4$	$3.65 + j0.1$
2000	$1.85 + j1.6$	$3.55 + j0.2$

$Z_{in}(1)$ = Conjugate of fixture gate terminal impedance.

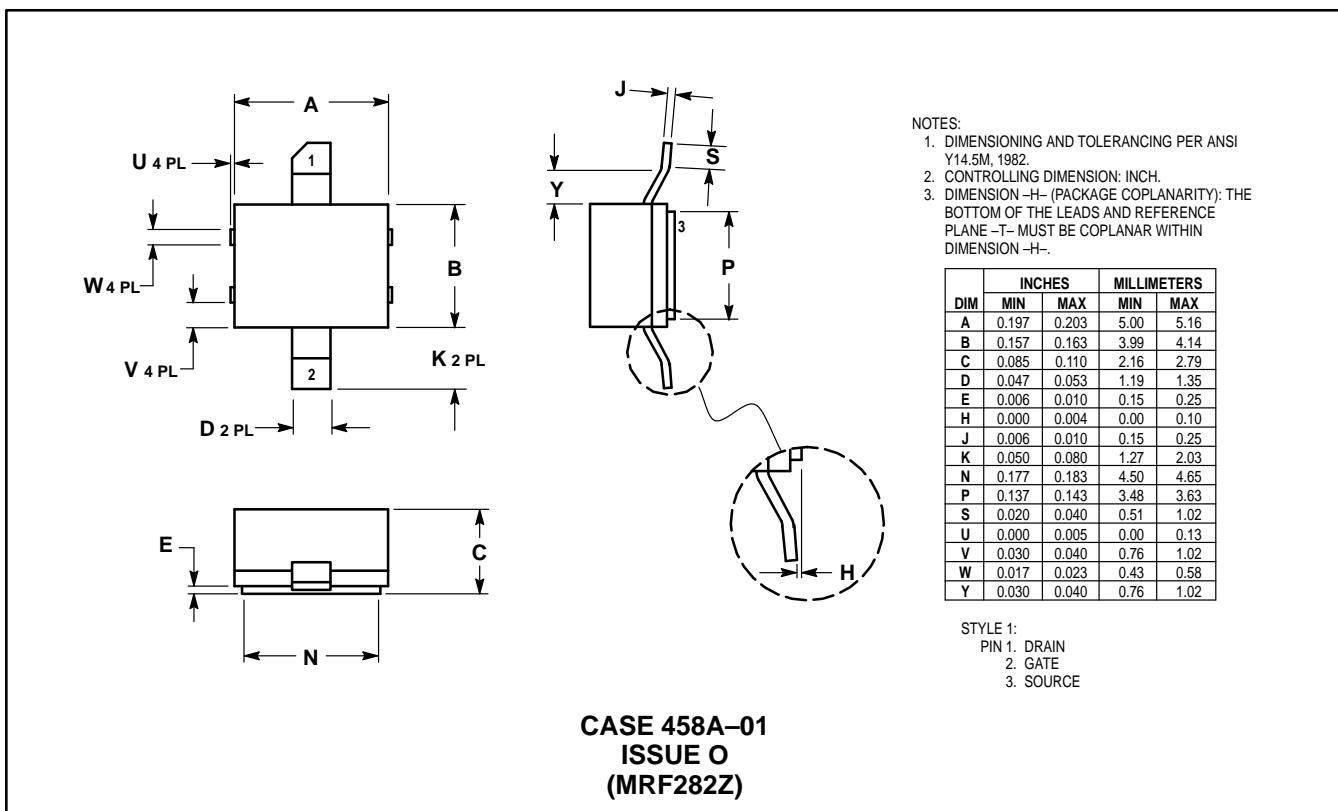
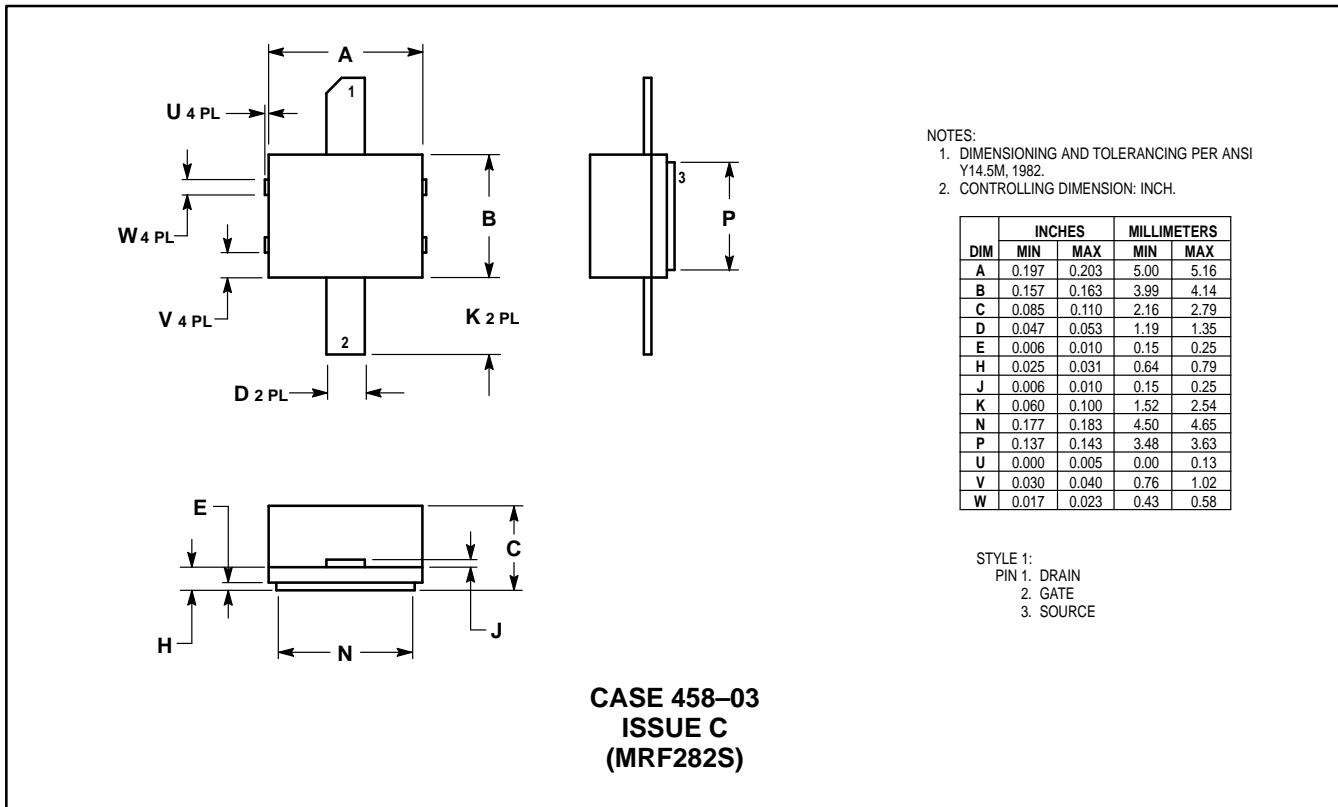
Z_{OL}^* = Conjugate of the optimum load impedance at given output power, voltage, IMD, bias current and frequency.

Figure 15. Series Equivalent Input and Output Impedance

Table 1. Common Source S–Parameters at $V_{DS} = 24$ Vdc, $I_D = 600$ mAdc

f GHz	S₁₁		S₂₁		S₁₂		S₂₂	
	S ₁₁	$\angle \phi$	S ₂₁	$\angle \phi$	S ₁₂	$\angle \phi$	S ₂₂	$\angle \phi$
0.1	0.916	-81	33.41	128	0.016	41	0.498	-60
0.2	0.850	-118	20.81	101	0.020	16	0.499	-88
0.3	0.843	-135	14.45	84	0.020	2	0.532	-106
0.4	0.848	-144	10.61	73	0.019	-7	0.552	-117
0.5	0.861	-151	8.34	63	0.017	-15	0.609	-125
0.6	0.872	-154	6.61	55	0.015	-19	0.647	-132
0.7	0.882	-158	5.43	47	0.013	-23	0.675	-139
0.8	0.895	-160	4.54	41	0.011	-24	0.728	-145
0.9	0.901	-163	3.82	34	0.009	-24	0.740	-150
1.0	0.902	-164	3.27	29	0.008	-18	0.773	-160
1.1	0.909	-166	2.83	24	0.006	-6	0.794	-164
1.2	0.917	-168	2.48	19	0.006	10	0.813	-168
1.3	0.923	-169	2.18	14	0.006	14	0.826	-172
1.4	0.931	-171	1.94	10	0.006	15	0.842	-176
1.5	0.933	-172	1.73	6	0.005	43	0.853	-179
1.6	0.934	-174	1.55	2	0.007	60	0.859	177
1.7	0.937	-175	1.40	-1	0.009	60	0.869	174
1.8	0.938	-176	1.27	-4	0.010	63	0.869	171
1.9	0.942	-177	1.16	-7	0.011	71	0.874	169
2.0	0.943	-178	1.06	-10	0.014	73	0.876	166
2.1	0.946	-178	0.98	-12	0.016	71	0.884	163
2.2	0.950	-179	0.92	-15	0.019	67	0.897	160
2.3	0.953	-180	0.86	-18	0.019	63	0.903	157
2.4	0.954	179	0.80	-21	0.020	62	0.907	154
2.5	0.955	178	0.76	-24	0.020	65	0.907	151
2.6	0.961	177	0.71	-26	0.024	69	0.912	149

PACKAGE DIMENSIONS



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